Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/588,439	Reexamination SUEMITSU ET A	L.
Examiner	Art Unit	
SYED HAIDER	2611	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0120421	06-2004	Filipovic, Daniel F.	375/316
*	В	US-2002/0176364	11-2002	Nakamura et al.	370/243
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN FATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-141821	05-2002	JAPAN	Akiyama	
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*	NON-FAIRNI DOCUMENTS				
_		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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